



Engineering Test Report No. 2202310-01

Report Date	August 9, 2022	
Manufacturer Name	Chamberlain Group, Inc.	
Manufacturer Address	300 Windsor Dr Oak Brook, IL 60523	
Test Item Name Model No.	Access Control Unit CAPXLVMC	
Date Received	July 20, 2022	
Test Date	July 20, 2022	
Specifications	FCC "Code of Federal Regulations" Title 47 Part 15, Subpart C, Section 15.247 Innovation, Science, and Economic Development Canada, RSS-GEN Innovation, Science, and Economic Development Canada, RSS-247	
Test Facility	Elite Electronic Engineering, Inc. 1516 Centre Circle, Downers Grove, IL 60515	FCC Reg. Number: 269750 IC Reg. Number: 2987A CAB Identifier: US0107
Signature	<i>Nathaniel Bouchie</i>	
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PO Number	4900084725	

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Table of Contents

1.	Report Revision History	3
2.	Introduction	4
2.1.	Scope of Tests	4
2.2.	Purpose	4
2.3.	Identification of the EUT	4
3.	Power Input	4
4.	Grounding	4
5.	Support Equipment	4
6.	Interconnect Leads	5
7.	Modifications Made to the EUT	5
8.	Mode of Operation	5
9.	Test Specifications	5
10.	Test Plan	5
11.	Deviation, Additions to, or Exclusions from Test Specifications	5
12.	Laboratory Conditions	5
13.	Summary	6
14.	Sample Calculations	6
15.	Statement of Conformity	6
16.	Certification	6
17.	Photographs of EUT	7
18.	Equipment List	9
19.	Block Diagram of Test Setup	10
20.	Carrier Frequency Separation	11
21.	Number of Carrier Channels	13
22.	Average Time of Occupancy	15
23.	Effective Isotropic Radiated Power (EIRP)	18
24.	Case Spurious Radiated Emissions	20
25.	Band-Edge Compliance	34
26.	Scope of Accreditation	38

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1. Report Revision History

Revision	Date	Description
–	10 AUG 2022	Initial Release of Engineering Test Report No. 2202310-01

2. Introduction

2.1. Scope of Tests

This document presents the results of a series of RF emissions tests that were performed on the Chamberlain Group, Inc. Access Control Unit (hereinafter referred to as the Equipment Under Test (EUT)). The EUT was manufactured and submitted for testing by Chamberlain Group, Inc. located in Oak Brook, IL.

2.2. Purpose

The test series was performed to determine if the EUT meets the RF emission requirements of the FCC "Code of Federal Regulations" Title 47, Part 15, Subpart C, §15.247 for a Frequency Hopping Spread Spectrum intentional radiator operating within the 902 – 928MHz band.

The test series was also performed to determine if the EUT meets the RF emission requirements of the Innovation, Science, and Economic Development Canada Radio Standards Specification RSS-Gen and Innovation, Science, and Economic Development Canada Radio Standards Specification RSS-247 for a Frequency Hopping Spread Spectrum intentional radiator operating within the 902 – 928MHz band.

The test series was performed to determine if the Chamberlain Group, Inc. Access Control Unit, FCC ID: HBW8439, meets the Class II Permissive Change requirements of the FCC "Code of Federal Regulations" Title 47, Part 15, Subpart C, §15.247. The following modifications have been made to the original equipment:

- An LED driver on the touchscreen was replaced such that the touchscreen part number changed.

2.3. Identification of the EUT

The EUT was identified as follows:

EUT Identification	
Product Description	Access Control Unit
Model/Part No.	CAPXLVMC
Serial No.	SMP-90182
Size of EUT	18 in x 14 in x 4.5 in
Software/Firmware Version	2.15.3.0
Device Type	Frequency Hopping Transmission Device
Band of Operation	902 – 928MHz
Modulation Type	GFSK
Antenna Type	Wire
Conducted Output Power	14.03 dBm (25.32 mW)
Rated Output Power	12 W
20dB Bandwidth	202.6 kHz
Occupied Bandwidth (99% CBW)	189.37 kHz
Emission Classification	189KF1D
Product FCC ID	FCC ID: HBW8439

Note 1 – Antenna gain is supplied by the manufacturer and Elite is not responsible for the accuracy of the antenna gain.

3. Power Input

The EUT obtained 120VAC 60Hz power via a 3 wire, unshielded power cord.

4. Grounding

The EUT was connected to ground through the third wire of its input power cord.

5. Support Equipment

No support equipment was used during the tests.

6. Interconnect Leads

No interconnect leads were used during the tests.

7. Modifications Made to the EUT

No modifications were made to the EUT during the testing.

8. Mode of Operation

The EUT and all peripheral equipment were energized. The unit was programmed to transmit in the following mode:

Mode	Description
Hopping Enabled	Tx Hopping in the 902-928MHz frequency range

9. Test Specifications

The tests were performed to selected portions of, and in accordance with, the following test specifications.

- Federal Communications Commission "Code of Federal Regulations", Title 47, Chapter I, Subchapter A, Part 15, Subpart C
- ANSI C63.10-2013, "American National Standard of Procedures for Compliance Testing of Unlicensed Wireless Devices"
- Federal Communications Commission Office of Engineering and Technology Laboratory Division, Guidance For Compliance Measurements On Digital Transmission Systems, Frequency Hopping Spread Spectrum System, and Hybrid System Devices Operating Under Section 15.247 April 2, 2019 KDB 558074 D01v05r02
- RSS-Gen Issue 5, February 2020, Amendment 2, Innovation, Science, and Economic Development Canada, "General Requirements for Compliance of Radio Apparatus"
- RSS-247 Issue 2, February 2017, "Digital Transmission Systems (DTSS), Frequency Hopping Systems (FHSs) and License-Exempt Local Area Network (LE-LAN) Devices"

10. Test Plan

No test plan was provided. Instructions were provided by personnel from Chamberlain Group, Inc. and used in conjunction with the FCC "Code of Federal Regulations" Title 47 Part 15, Subpart C, Section 15.247, Innovation, Science, and Economic Development Canada, RSS-247 and test methods described in ANSI C63.10-2013- specifications.

11. Deviation, Additions to, or Exclusions from Test Specifications

There were no deviations, additions to, or exclusions from the test specifications during this test series.

12. Laboratory Conditions

The ambient parameters of the laboratory during testing were as follows:

Ambient Parameters	Value
Temperature	24°C
Relative Humidity	40%
Atmospheric Pressure	1009.6mb

13. Summary

The following EMC tests were performed, and the results are shown below:

Test Description	Requirements	Test Method	S/N	Results
Carrier Frequency Separation	FCC 15.247 ISED RSS-247	ANSI C63.10:2013	SMP-90182	Conforms
Number of Carrier Channels	FCC 15.247 ISED RSS-247	ANSI C63.10:2013	SMP-90182	Conforms
Average Time of Occupancy	FCC 15.247 ISED RSS-247	ANSI C63.10:2013	SMP-90182	Conforms
Effective Isotropic Radiated Power (EIRP)	FCC 15.247 ISED RSS-247	ANSI C63.10:2013	SMP-90182	Conforms
Case Spurious Radiated Emissions	FCC 15.247 ISED RSS-247	ANSI C63.10:2013	SMP-90182	Conforms
Band-Edge Compliance	FCC 15.247 ISED RSS-247	ANSI C63.10:2013	SMP-90182	Conforms

14. Sample Calculations

For Powerline Conducted Emissions:

The resultant voltage level (VL) is a summation in decibels (dB) of the receiver meter reading (MTR) and the cable loss factor (CF).

$$\text{Formula 1: } VL \text{ (dB}\mu\text{V)} = \text{MTR (dB}\mu\text{V)} + \text{CF (dB)}.$$

For Radiated Emissions:

The resultant field strength (FS) is a summation in decibels (dB) of the receiver meter reading (MTR), the antenna correction factor (AF), and the cable loss factor (CF). If an external preamplifier is used, the total is reduced by its gain (-PA). If a distance correction (DC) is required, it is added to the total.

$$\text{Formula 1: } FS \text{ (dB}\mu\text{V/m)} = \text{MTR (dB}\mu\text{V)} + \text{AF (dB/m)} + \text{CF (dB)} + (- \text{PA (dB)}) + \text{DC (dB)}$$

To convert the Field Strength dB μ V/m term to μ V/m, the dB μ V/m is first divided by 20. The Base 10 AntiLog is taken of this quotient. The result is the Field Strength value in μ V/m terms.

$$\text{Formula 2: } FS \text{ (}\mu\text{V/m)} = \text{AntiLog} [(FS \text{ (dB}\mu\text{V/m)})/20]$$

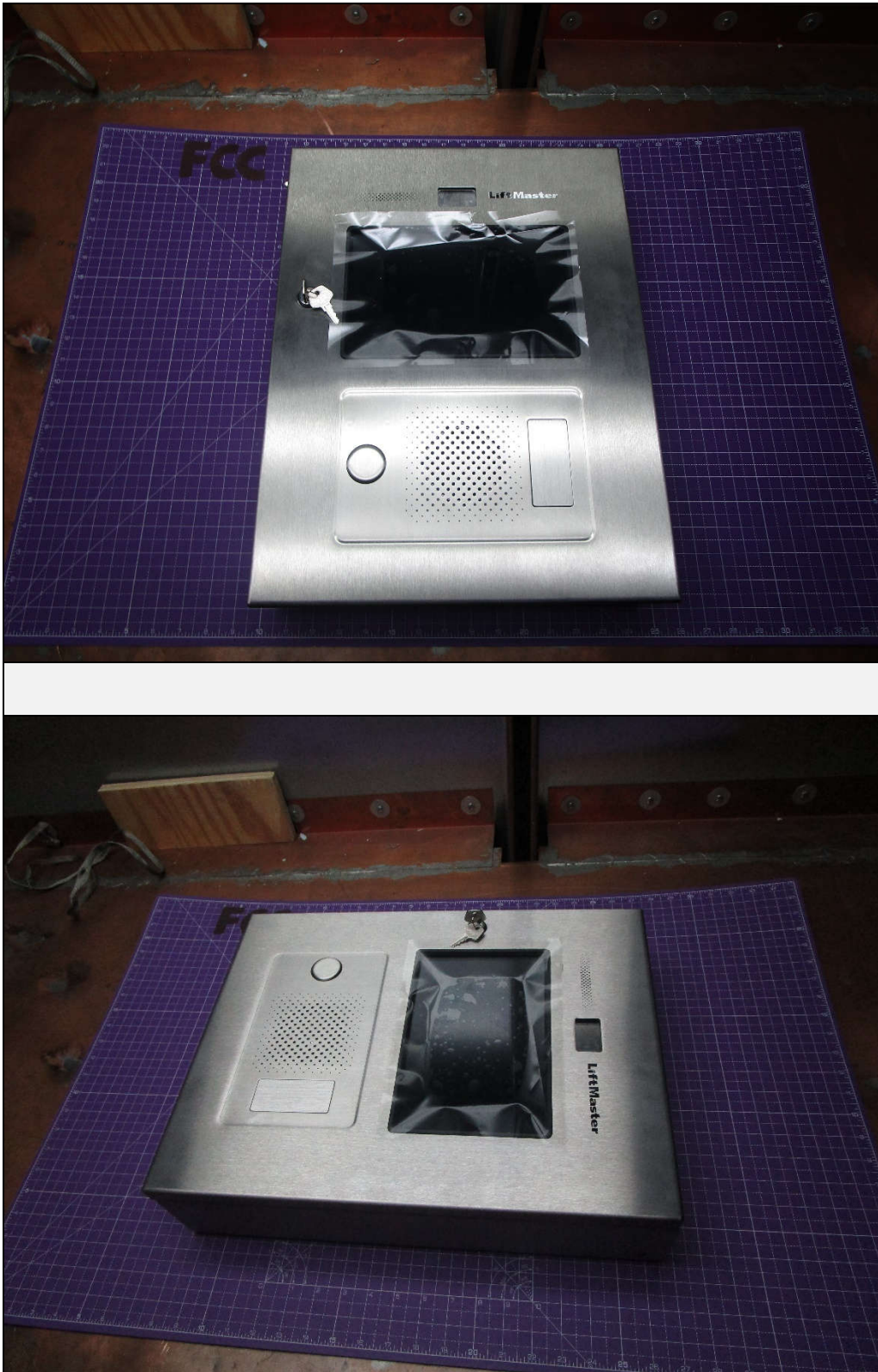
15. Statement of Conformity

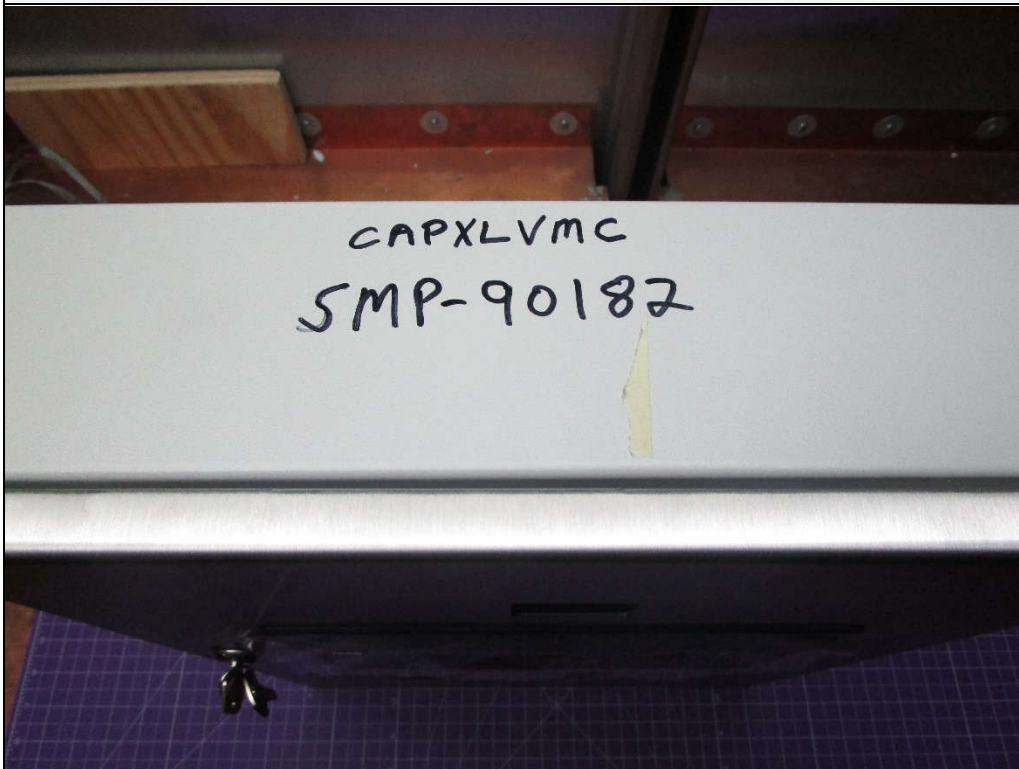
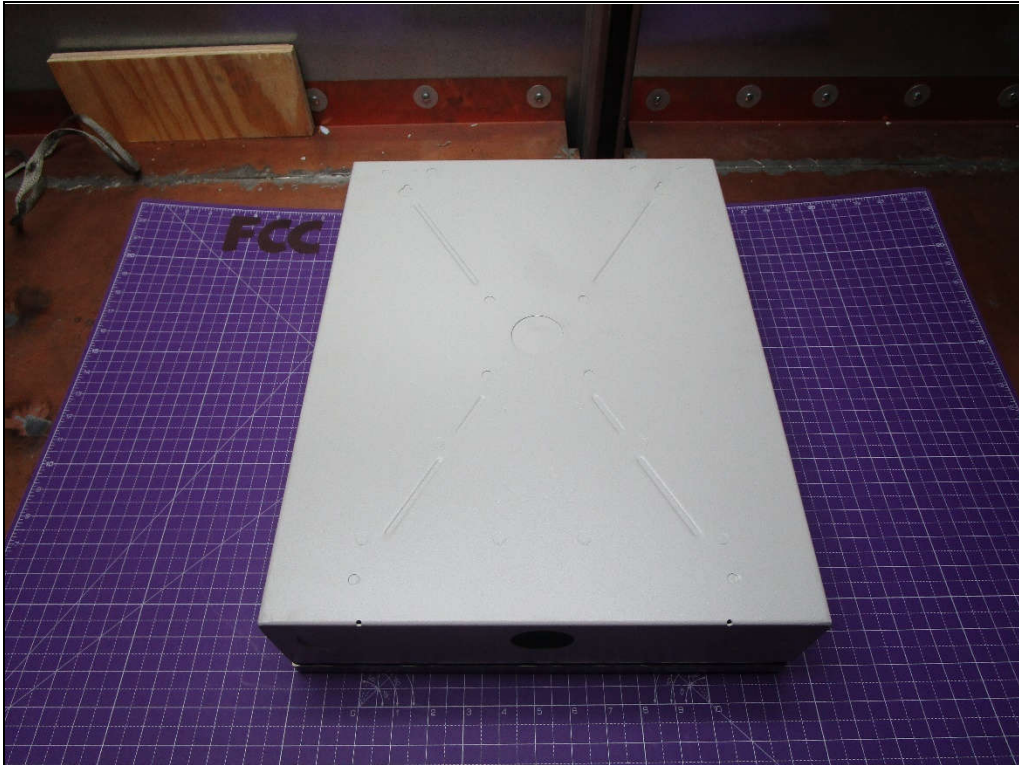
The Chamberlain Group, Inc. Access Control Unit (Model No. CAPXLVMC, Serial No. SMP-90182) did fully conform to the selected requirements of FCC "Code of Federal Regulations" Title 47 Part 15, Subpart C, Section 15.247 and Innovation, Science, and Economic Development Canada, RSS-247.

16. Certification

Elite Electronic Engineering Incorporated certifies that the information contained in this report was obtained under conditions which meet or exceed those specified in the FCC "Code of Federal Regulations" Title 47 Part 15, Subpart C, Section 15.247 and Innovation, Science, and Economic Development Canada, RSS-247 test specifications. The data presented in this test report pertains to the EUT on the test date specified. Any electrical or mechanical modifications made to the EUT subsequent to the specified test date will serve to invalidate the data and void this certification.

17. Photographs of EUT





18. Equipment List

Eq ID	Equipment Description	Manufacturer	Model No.	Serial No.	Frequency Range	Cal Date	Due Date
APW14	PREAMPLIFIER	PLANAR	PE2-35-120-5R0-10-12-SFF	PL22671	1-20GHz	9/21/2021	9/21/2022
CDZ3	LAB WORKSTATION	ELITE	LWS-10		WINDOWS 10	CNR	
NTA3	BILOG ANTENNA	TESEQ	6112D	32853	25-1000MHz	10/20/2020	10/20/2022
NWQ2	DOUBLE RIDGED WAVEGUIDE ANTENNA	ETS LINDGREN	3117	66659	1GHZ-18GHZ	4/27/2022	4/27/2024
R29F	3M ANECHOIC CHAMBER NSA	EMC TEST SYSTEMS	3M ANECHOIC		30MHZ-18GHZ	3/25/2022	3/25/2023
RBG2	EMI ANALYZER	ROHDE & SCHWARZ	ESW44	101591	2HZ-44GHZ	3/31/2022	3/31/2023
XPQ3	HIGH PASS FILTER	K&L MICROWAVE	4IH30-1804/T10000-0	4	1.8GHZ-10GHZ	9/7/2021	9/7/2023

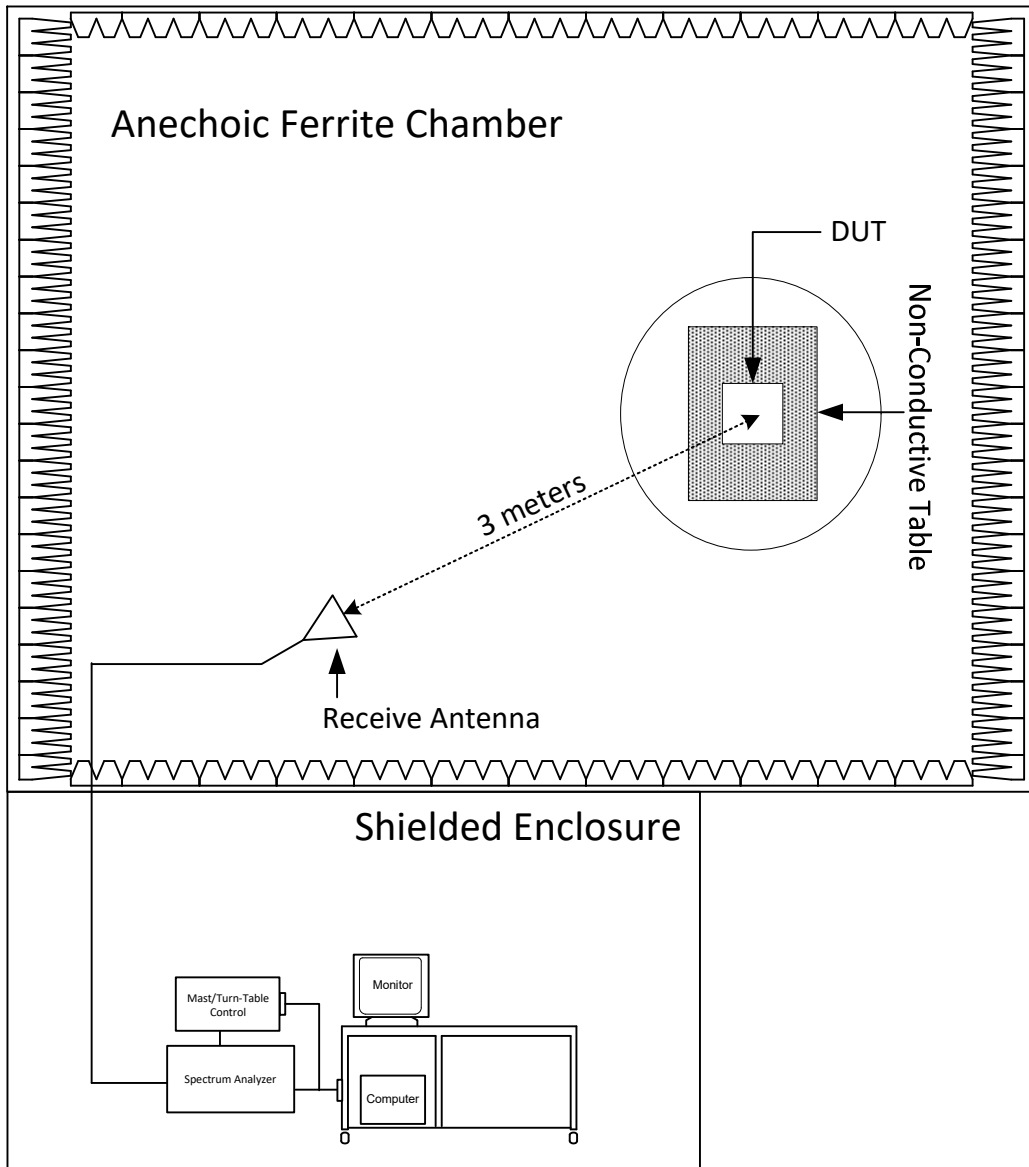
N/A: Not Applicable

I/O: Initial Only

CNR: Calibration Not Required

NOTE 1: For the purpose of this test, the equipment was calibrated over the specified frequency range, pulse rate, or modulation prior to the test or monitored by a calibrated instrument.

19. Block Diagram of Test Setup



Radiated Measurements Test Setup

20. Carrier Frequency Separation

EUT Information	
Manufacturer	Chamberlain Group, Inc.
Product	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping

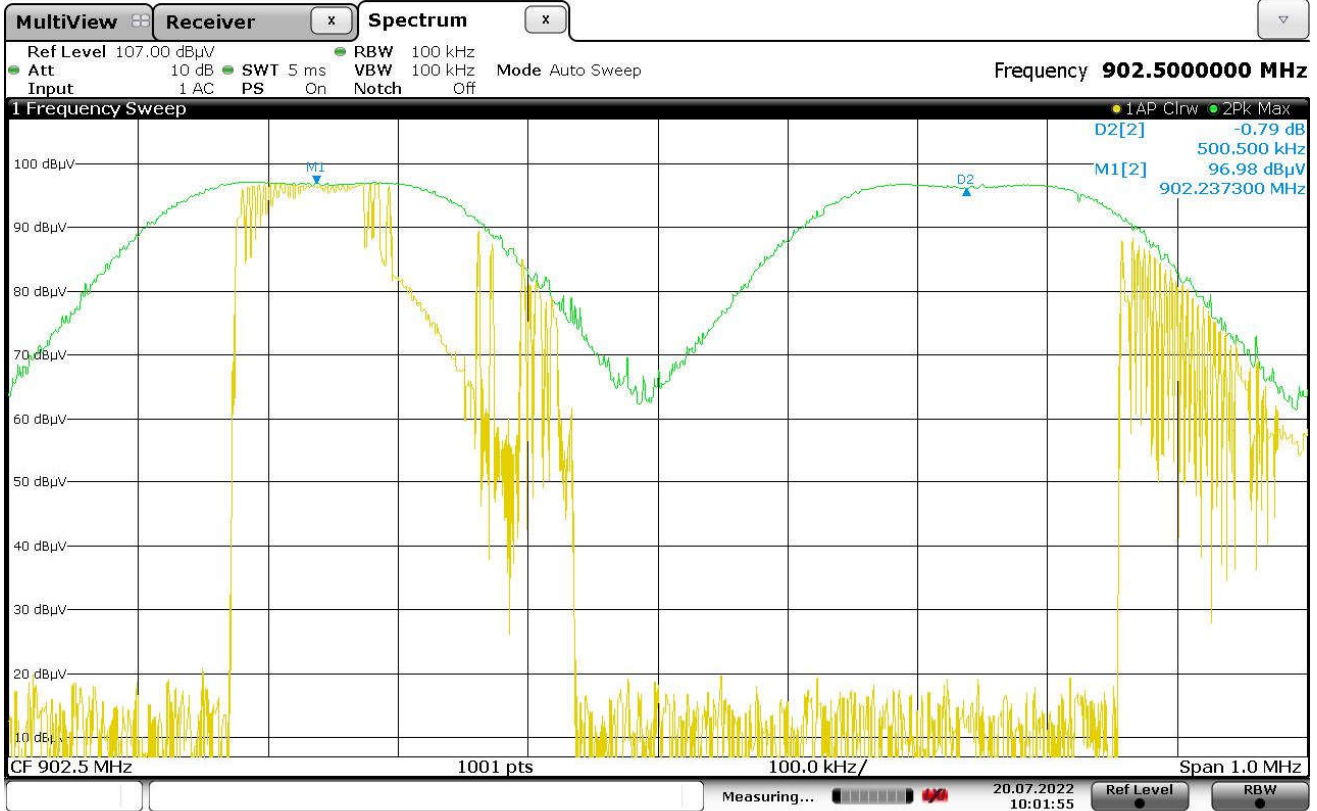
Test Setup Details	
Setup Format	Tabletop
Height of Support	N/A
Measurement Method	Radiated
Type of Test Site	Semi-Anechoic Chamber
Test Site Used	Room 29
Type of Antennas Used	Below 1GHz: Bilog (or equivalent) Above 1GHz: Double-ridged waveguide (or equivalent)
Notes	None

Measurement Uncertainty	
Measurement Type	Expanded Measurement Uncertainty
Radiated disturbance (electric field strength on an open area test site or alternative test site) (30 MHz – 1000 MHz)	4.3
Radiated disturbance (electric field strength on an open area test site or alternative test site) (1 GHz – 6 GHz)	3.1

Requirement
Channel carrier frequencies shall be separated by a minimum of 25kHz or the 20dB bandwidth, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5MHz band may have hopping channel carrier frequencies that are separated by 25kHz or two-thirds of the 20dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125mW.

Procedure
<p>The EUT was set up inside the chamber. With the hopping function enabled, the EUT was allowed to transmit continuously.</p> <p>Span was set wide enough to capture the peaks of two adjacent channels. The resolution bandwidth was set to approximately 30% of the channel spacing. The peak detector and 'Max-Hold' function were engaged. The span was set wide enough to capture the peaks of at least two adjacent channels. When the trace had stabilized after multiple scans, the marker-delta function was used to determine the separation between the peaks of the adjacent channels. The analyzer's display was plotted using a 'screen dump' utility.</p>

Test Details	
Manufacturer	Chamberlain Group, Inc.
EUT	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping
Frequency Tested	902.25MHz and 902.75MHz
Result	Separation = 500kHz
Notes	None



Date: 20.JUL.2022 10:01:55

21. Number of Carrier Channels

EUT Information	
Manufacturer	Chamberlain Group, Inc.
Product	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping

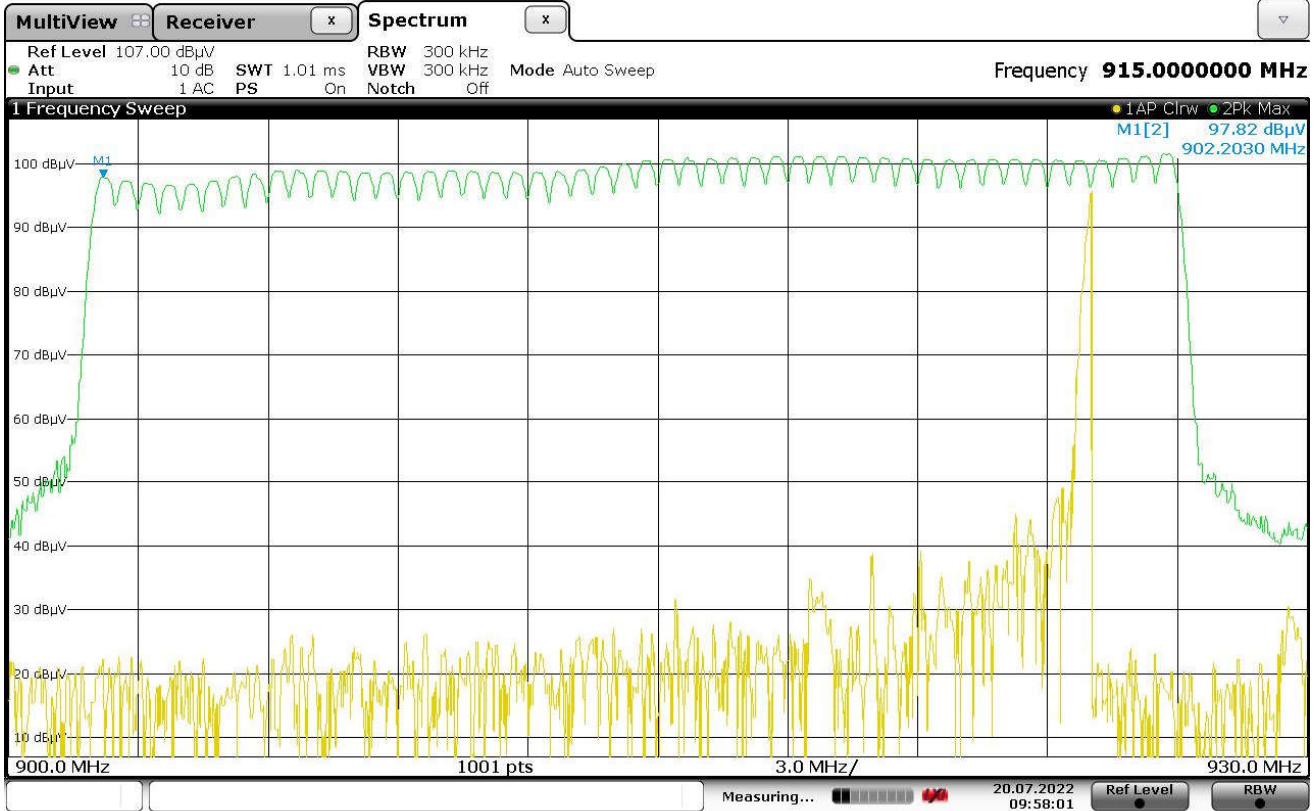
Test Setup Details	
Setup Format	Tabletop
Height of Support	N/A
Measurement Method	Radiated
Type of Test Site	Semi-Anechoic Chamber
Test Site Used	Room 29
Type of Antennas Used	Bilog (or equivalent)
Notes	None

Measurement Uncertainty	
Measurement Type	Expanded Measurement Uncertainty
Radiated disturbance (electric field strength on an open area test site or alternative test site) (30 MHz – 1000 MHz)	4.3
Radiated disturbance (electric field strength on an open area test site or alternative test site) (1 GHz – 6 GHz)	3.1

Requirements
The system shall use at least 50 hopping frequencies.

Procedure
<p>The EUT was set up inside the chamber. With the hopping function enabled, the EUT was allowed to transmit continuously.</p> <p>The resolution bandwidth (RBW) was set to less than 30% of the channel spacing or the 20dB bandwidth, whichever is smaller. The peak detector and 'Max-Hold' function were engaged. The span was set wide enough to capture the entire frequency band of operation.</p> <p>The EUT's signal was allowed to stabilize after multiple scans. The number of hopping frequencies was counted. The analyzer's display was plotted using a 'screen dump' utility.</p>

Test Details	
Manufacturer	Chamberlain Group, Inc.
EUT	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping
Frequency Tested	902-928MHz
Result	50 hopping frequencies
Notes	None



Date: 20.JUL.2022 09:58:01

22. Average Time of Occupancy

EUT Information	
Manufacturer	Chamberlain Group, Inc.
Product	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping

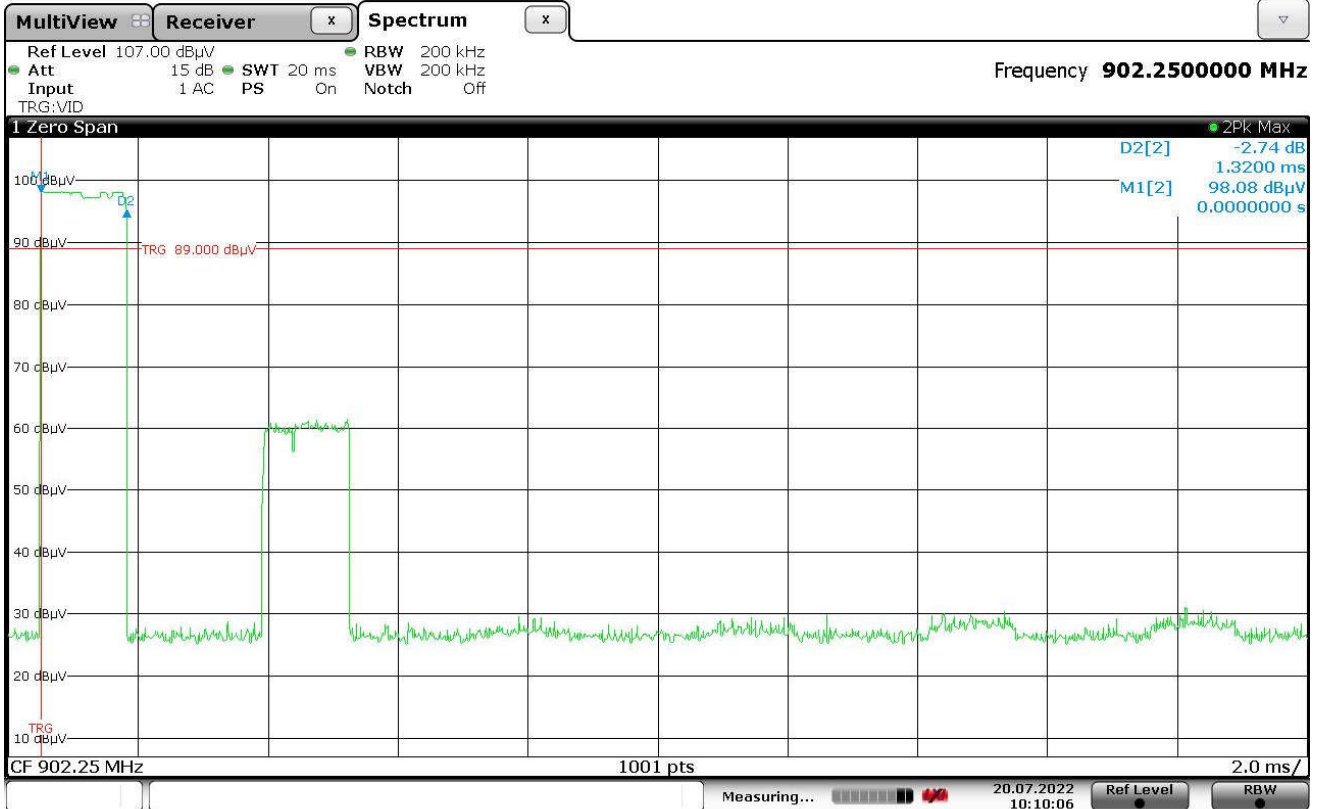
Test Setup Details	
Setup Format	Tabletop
Height of Support	N/A
Measurement Method	Radiated
Type of Test Site	Semi-Anechoic Chamber
Test Site Used	Room 29
Type of Antennas Used	Below 1GHz: Bilog (or equivalent) Above 1GHz: Double-ridged waveguide (or equivalent)
Notes	None

Measurement Uncertainty	
Measurement Type	Expanded Measurement Uncertainty
Radiated disturbance (electric field strength on an open area test site or alternative test site) (30 MHz – 1000 MHz)	4.3
Radiated disturbance (electric field strength on an open area test site or alternative test site) (1 GHz – 6 GHz)	3.1

Requirements
The average time of occupancy on any frequency shall not be greater than 0.4 seconds within a 20 second period.

Procedure
<p>The EUT was set up inside the chamber. With the hopping function enabled, the EUT was allowed to transmit continuously.</p> <p>The spectrum analyzer was set to zero span centered on a hopping channel. The resolution bandwidth (RBW) was set \geq to the channel spacing. The sweep was set to capture the entire dwell time per hopping channel. The peak detector and 'Max-Hold' function were engaged. The analyzer's display was plotted using a 'screen dump' utility.</p>

Test Details	
Manufacturer	Chamberlain Group, Inc.
EUT	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping
Frequency Tested	902-928MHz
Result	Ave. Time of Occupancy = 0.14784s
Notes	Time per pulse = 1.32ms



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Test Details	
Manufacturer	Chamberlain Group, Inc.
EUT	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping
Frequency Tested	902-928MHz
Result	Ave. Time of Occupancy = 0.14784s
Notes	Pulses in 20s = 112 112 * 1.32ms = 147.84ms = 0.14784s



Date: 20.JUL.2022 11:53:01

23. Effective Isotropic Radiated Power (EIRP)

EUT Information	
Manufacturer	Chamberlain Group, Inc.
Product	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping

Test Setup Details	
Setup Format	Tabletop
Height of Support	N/A
Measurement Method	Radiated
Type of Test Site	Semi-Anechoic Chamber
Test Site Used	Room 29
Type of Antennas Used	Bilog (or equivalent)
Notes	None

Measurement Uncertainty	
Measurement Type	Expanded Measurement Uncertainty
Radiated disturbance (electric field strength on an open area test site or alternative test site) (30 MHz – 1000 MHz)	4.3
Radiated disturbance (electric field strength on an open area test site or alternative test site) (1 GHz – 6 GHz)	3.1

Requirements
The output power shall not exceed 4W (36dBm).

Procedure
<p>The EUT was placed on the non-conductive stand and set to transmit. A bilog antenna was placed at a test distance of 3 meters from the EUT. The resolution bandwidth (RBW) of the spectrum analyzer was set to greater than the 20dB bandwidth. The span was set to approximately 5 times the 20 dB bandwidth. The EUT was maximized for worst case emissions (or maximum output power) at the measuring antenna. The maximum meter reading was recorded. The peak power output was measured for the low, middle, and high hopping frequencies.</p> <p>The equivalent power was determined from the field intensity levels measured at 3 meters using the substitution method. To determine the emission power, a dipole antenna (double ridged waveguide antenna for all measurements above 1GHz) was then set in place of the EUT and connected to a calibrated signal generator. The output of the signal generator was adjusted to match the received level at the spectrum analyzer. The signal level was recorded. The reading was then corrected to compensate for cable loss (and antenna gain for all measurements above 1GHz), as required. The peak power output was calculated for low, middle, and high hopping frequencies.</p>

Test Details	
Manufacturer	Chamberlain Group, Inc.
EUT	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping
Result	Max EIRP = 0.032W (15dBm)
Notes	None

Freq (MHz)	Ant Pol	Wide BW Meter Reading (dBμV)	Cable Factor (dB)	Antenna Factor (dB/m)	Pre Amp (dB)	Peak Total (dBμV/m)	EIRP (dBm)	Limit (dBm)	Margin (dB)
902.25	H	81.2	1.5	26.5	0.0	109.2	13.9	30.0	-16.1
	V	82.3	1.5	26.5	0.0	110.3	15.0	30.0	-15.0
914.75	H	80.43	1.6	26.3	0.0	108.3	13.0	30.0	-17.0
	V	81.95	1.6	26.3	0.0	109.8	14.5	30.0	-15.5
926.75	H	80.58	1.6	26.7	0.0	108.8	13.5	30.0	-16.5
	V	80	1.6	26.7	0.0	108.2	12.9	30.0	-17.1

24. Case Spurious Radiated Emissions

EUT Information	
Manufacturer	Chamberlain Group, Inc.
Product	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping

Test Setup Details	
Setup Format	Tabletop
Height of Support	N/A
Type of Test Site	Semi-Anechoic Chamber
Test Site Used	Room 29
Type of Antennas Used	Below 1GHz: Bilog (or equivalent) Above 1GHz: Double-Ridged Waveguide (or equivalent)
Notes	N/A

Measurement Uncertainty	
Measurement Type	Expanded Measurement Uncertainty
Radiated disturbance (electric field strength on an open area test site or alternative test site) (30 MHz – 1000 MHz)	4.3
Radiated disturbance (electric field strength on an open area test site or alternative test site) (1 GHz – 6 GHz)	3.1
Radiated disturbance (electric field strength on an open area test site or alternative test site) (6 GHz – 18 GHz)	3.2
Radiated disturbance (electric field strength on an open area test site or alternative test site) (18 GHz – 26.5 GHz)	3.3
Radiated disturbance (electric field strength on an open area test site or alternative test site) (26.5 GHz – 40 GHz)	3.4

Procedure

Radiated measurements were performed in a 32ft. x 20ft. x 14ft. high shielded enclosure. The shielded enclosure prevents emissions from other sources, such as radio and TV stations from interfering with the measurements. All powerlines and signal lines entering the enclosure pass through filters on the enclosure wall. The powerline filters prevent extraneous signals from entering the enclosure on these leads.

Preliminary radiated emissions tests were performed to determine the emission characteristics of the EUT. For the preliminary test, a broadband measuring antenna was positioned at a 3-meter distance from the EUT. The entire frequency range from 30MHz to 10.0GHz was investigated using a peak detector function.

The final open field emission tests were then manually performed over the frequency range of 30MHz to 10.0GHz.

1) For all harmonics not in the restricted bands, the following procedure was used:

- a) The field strength of the fundamental was measured using a bilog antenna. The bilog antenna was positioned at a 3-meter distance from the EUT. The EUT was placed on an 80 cm high non-conductive stand. A peak detector with a resolution bandwidth of 100 kHz was used on the spectrum analyzer.
- b) The field strengths of all of the harmonics not in the restricted band were then measured using a double-ridged waveguide antenna. The waveguide antenna was positioned at a 3-meter distance from the EUT. The EUT was placed on a 1.5-meter-high non-conductive stand. A peak detector with a resolution bandwidth of 100kHz was used on the spectrum analyzer.
- c) To ensure that maximum or worst-case emission levels at the fundamental and harmonics were measured, the following steps were taken when measuring the fundamental emissions and the spurious emissions:
 - i) The EUT was rotated so that all of its sides were exposed to the receiving antenna.
 - ii) Since the measuring antenna is linearly polarized, both horizontal and vertical field components were measured.
 - iii) The measuring antenna was raised and lowered for each antenna polarization to maximize the readings.
 - iv) In instances where it was necessary to use a shortened cable between the measuring antenna and the spectrum analyzer, the measuring antenna was not raised or lowered to ensure maximized readings. Instead, the EUT was rotated through all axis to ensure the maximum readings were recorded for the EUT.
- d) All harmonics not in the restricted bands must be at least 20dB below levels measured at the fundamental. However, attenuation below the general limits specified in §15.209(a) is not required.

2) For all emissions in the restricted bands, the following procedure was used:

- a) The field strengths of all emissions below 1GHz were measured using a bi-log antenna. The bi-log antenna was positioned at a 3-meter distance from the EUT. The EUT was placed on an 80cm high non-conductive stand. A peak detector with a resolution bandwidth of 100 kHz was used on the spectrum analyzer.
- b) The field strengths of all emissions above 1GHz were measured using a double-ridged waveguide antenna. The waveguide antenna was positioned at a 3-meter distance from the EUT. The EUT was placed on a 1.5-meter-high non-conductive stand. A peak detector with a resolution bandwidth of 1MHz was used on the spectrum analyzer.
- c) To ensure that maximum or worst-case emission levels were measured, the following steps were taken when taking all measurements:
 - i) The EUT was rotated so that all of its sides were exposed to the receiving antenna.
 - ii) Since the measuring antenna is linearly polarized, both horizontal and vertical field components

were measured.

- iii) The measuring antenna was raised and lowered for each antenna polarization to maximize the readings.
- iv) In instances where it was necessary to use a shortened cable between the measuring antenna and the spectrum analyzer, the measuring antenna was not raised or lowered to ensure maximized readings. Instead, the EUT was rotated through all axis to ensure the maximum readings were recorded for the EUT.
- d) For all radiated emissions measurements below 1GHz, if the peak reading is below the limits listed in §15.209(a), no further measurements are required. If, however, the peak readings exceed the limits listed in §15.209(a), then the emissions are remeasured using a quasi-peak detector.
- e) For all radiated emissions measurements above 1GHz, the peak readings must comply with the §15.35(b) limits. §15.35(b) states that when average radiated emissions measurements are specified, there also is a limit on the peak level of the radiated emissions. The limit on the peak radio frequency emissions is 20dB above the maximum permitted average emission limit applicable to the equipment under test. Therefore, all peak readings above 1GHz must be no greater than 20dB above the limits specified in §15.209(a).
- f) Next, for all radiated emissions measurements above 1GHz, the resolution bandwidth was set to 1MHz. The analyzer was set to linear mode with a 10Hz video bandwidth in order to simulate an average detector. An average reading was taken.

If the dwell time per channel of the hopping signal is less than 100msec, then the reading obtained with the 10Hz video bandwidth may be further adjusted by a duty cycle correction factor derived from $20 \cdot \log(\text{dwell time}/100\text{msec})$. These readings must be no greater than the limits specified in §15.209(a).



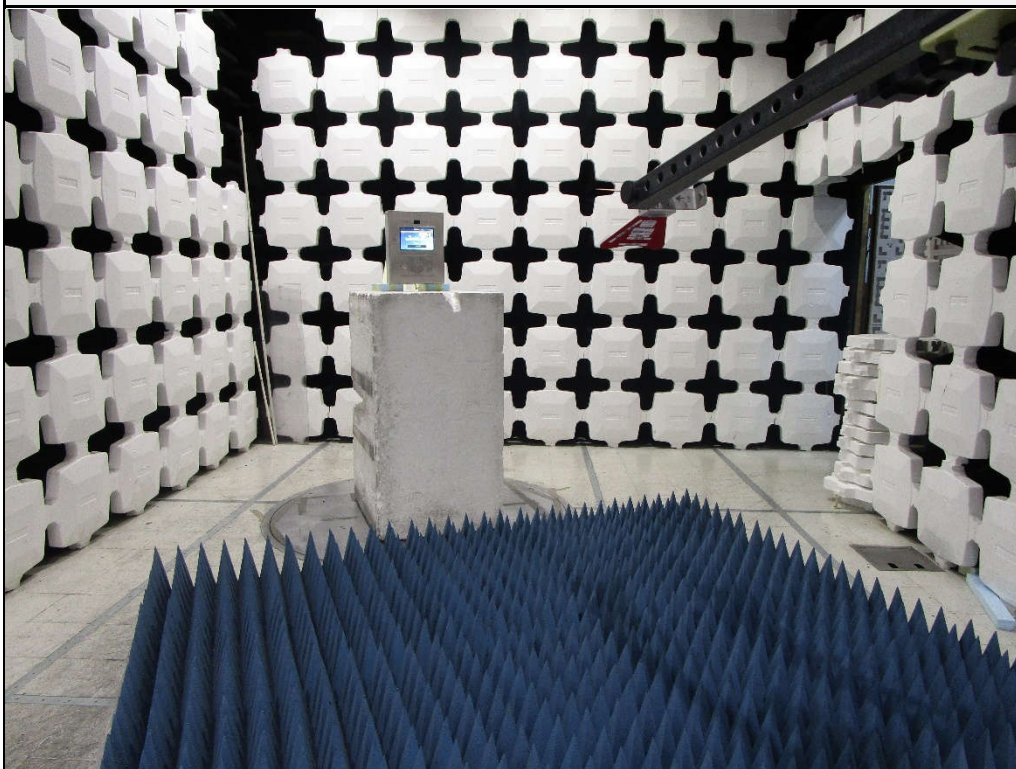
Test Setup for Spurious Radiated Emissions, 30MHz – 1GHz – Antenna Polarization Horizontal



Test Setup for Spurious Radiated Emissions, 30MHz – 1GHz – Antenna Polarization Vertical



Test Setup for Spurious Radiated Emissions, Above 1GHz – Antenna Polarization Horizontal



Test Setup for Spurious Radiated Emissions, Above 1GHz – Antenna Polarization Vertical

Test Details	
Manufacturer	Chamberlain Group, Inc.
EUT	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping
Frequency Tested	902.25MHz
Notes	Peak Measurements in the Restricted Bands

Freq (MHz)	Ant Pol	Meter Reading (dBμV)	Ambient	Cable Factor (dB)	Antenna Factor (dB/m)	Pre Amp (dB)	Peak Total at 3m (dBμV/m)	Peak Total at 3m (μV/m)	Peak Limit at 3m (μV/m)	Margin (dBm)
2706.75	H	54.3		2.8	33.4	-40.2	50.3	328.3	5000.0	-23.7
	V	55.2		2.8	33.4	-40.2	51.3	365.4	5000.0	-22.7
3609.00	H	60.0		3.2	34.6	-39.5	58.3	824.0	5000.0	-15.7
	V	56.3		3.2	34.6	-39.5	54.6	538.8	5000.0	-19.4

Test Details	
Manufacturer	Chamberlain Group, Inc.
EUT	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping
Frequency Tested	902.25MHz
Notes	Average Measurements in the Restricted Bands

Freq (MHz)	Ant Pol	Meter Reading (dBμV)	Ambient	CBL Fac (dB)	Ant Fac (dB/m)	Pre Amp (dB)	Duty Cycle Factor (dB)	Average Total at 3m (dBμV/m)	Average Total at 3m (μV/m)	Average Limit at 3m (μV/m)	Margin (dB)
2706.75	H	54.3		2.8	33.4	-40.2	-37.7	12.6	4.3	500.0	-41.4
	V	55.2		2.8	33.4	-40.2	-37.7	13.6	4.8	500.0	-40.4
3609.00	H	60.0		3.2	34.6	-39.5	-37.7	20.6	10.7	500.0	-33.4
	V	56.3		3.2	34.6	-39.5	-37.7	16.9	7.0	500.0	-37.1

Test Details	
Manufacturer	Chamberlain Group, Inc.
EUT	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping
Frequency Tested	902.25MHz
Notes	Peak Measurements in Non-Restricted Bands

Freq (MHz)	Ant Pol	Meter Reading (dBμV)	Ambient	Cable Factor (dB)	Antenna Factor (dB/m)	Pre Amp (dB)	Peak Total at 3m (dBμV/m)	Peak Total at 3m (μV/m)	Peak Limit at 3m (μV/m)	Margin (dBm)
902.25	H	81.0		1.5	26.5	0.0	109.0	282615.4	NA	NA
	V	82.3		1.5	26.5	0.0	110.3	328243.2	NA	NA
1804.50	H	54.5		2.2	31.5	-40.1	48.1	254.5	32824.3	-42.2
	V	56.8		2.2	31.5	-40.1	50.4	330.5	32824.3	-39.9

Test Details	
Manufacturer	Chamberlain Group, Inc.
EUT	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping
Frequency Tested	914.75MHz
Notes	Peak Measurements in the Restricted Bands

Freq (MHz)	Ant Pol	Meter Reading (dBµV)	Ambient	Cable Factor (dB)	Antenna Factor (dB/m)	Pre Amp (dB)	Peak Total at 3m (dBµV/m)	Peak Total at 3m (µV/m)	Peak Limit at 3m (µV/m)	Margin (dBm)
2744.25	H	60.1		2.8	33.2	-40.2	55.9	624.0	5000.0	-18.1
	V	61.4		2.8	33.2	-40.2	57.2	724.7	5000.0	-16.8
3659.00	H	60.0		3.3	34.8	-39.5	58.6	846.5	5000.0	-15.4
	V	57.9		3.3	34.8	-39.5	56.4	663.2	5000.0	-17.5

Test Details	
Manufacturer	Chamberlain Group, Inc.
EUT	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping
Frequency Tested	914.75MHz
Notes	Average Measurements in the Restricted Bands

Freq (MHz)	Ant Pol	Meter Reading (dB μ V)	Ambient	CBL Fac (dB)	Ant Fac (dB/m)	Pre Amp (dB)	Duty Cycle Factor (dB)	Average Total at 3m (dB μ V/m)	Average Total at 3m (μ V/m)	Average Limit at 3m (μ V/m)	Margin (dB)
2744.25	H	60.1		2.8	33.2	-40.2	-37.7	18.2	8.1	500.0	-35.8
	V	61.4		2.8	33.2	-40.2	-37.7	19.5	9.4	500.0	-34.5
3659.00	H	60.0		3.3	34.8	-39.5	-37.7	20.9	11.0	500.0	-33.1
	V	57.9		3.3	34.8	-39.5	-37.7	18.7	8.6	500.0	-35.2

Test Details	
Manufacturer	Chamberlain Group, Inc.
EUT	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping
Frequency Tested	914.75MHz
Notes	Peak Measurements in Non-Restricted Bands

Freq (MHz)	Ant Pol	Meter Reading (dBμV)	Ambient	Cable Factor (dB)	Antenna Factor (dB/m)	Pre Amp (dB)	Peak Total at 3m (dBμV/m)	Peak Total at 3m (μV/m)	Peak Limit at 3m (μV/m)	Margin (dBm)
914.75	H	78.6		1.6	26.3	0.0	106.5	211641.0	NA	NA
	V	81.5		1.6	26.3	0.0	109.3	293156.6	NA	NA
1829.50	H	59.3		2.2	31.7	-40.1	53.1	451.4	32824.3	-37.2
	V	59.4		2.2	31.7	-40.1	53.2	455.1	32824.3	-37.2

Test Details	
Manufacturer	Chamberlain Group, Inc.
EUT	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping
Frequency Tested	926.75MHz
Notes	Peak Measurements in the Restricted Bands

Freq (MHz)	Ant Pol	Meter Reading (dBμV)	Ambient	Cable Factor (dB)	Antenna Factor (dB/m)	Pre Amp (dB)	Peak Total at 3m (dBμV/m)	Peak Total at 3m (μV/m)	Peak Limit at 3m (μV/m)	Margin (dBm)
2780.25	H	54.4		2.8	32.9	-40.1	50.0	316.8	5000.0	-24.0
	V	56.2		2.8	32.9	-40.1	51.8	388.9	5000.0	-22.2
3707.00	H	58.7		3.3	34.4	-39.5	56.9	700.5	5000.0	-17.1
	V	57.0		3.3	34.4	-39.5	55.2	574.0	5000.0	-18.8

Test Details	
Manufacturer	Chamberlain Group, Inc.
EUT	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping
Frequency Tested	926.75MHz
Notes	Average Measurements in the Restricted Bands

Freq (MHz)	Ant Pol	Meter Reading (dB μ V)	Ambient	CBL Fac (dB)	Ant Fac (dB/m)	Pre Amp (dB)	Duty Cycle Factor (dB)	Average Total at 3m (dB μ V/m)	Average Total at 3m (μ V/m)	Average Limit at 3m (μ V/m)	Margin (dB)
2780.25	H	54.4		2.8	32.9	-40.1	-37.7	12.3	4.1	500.0	-41.7
	V	56.2		2.8	32.9	-40.1	-37.7	14.1	5.1	500.0	-39.9
3707.00	H	58.7		3.3	34.4	-39.5	-37.7	19.2	9.1	500.0	-34.8
	V	57.0		3.3	34.4	-39.5	-37.7	17.5	7.5	500.0	-36.5

Test Details	
Manufacturer	Chamberlain Group, Inc.
EUT	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping
Frequency Tested	926.75MHz
Notes	Peak Measurements in Non-Restricted Bands

Freq (MHz)	Ant Pol	Meter Reading (dBμV)	Ambient	Cable Factor (dB)	Antenna Factor (dB/m)	Pre Amp (dB)	Peak Total at 3m (dBμV/m)	Peak Total at 3m (μV/m)	Peak Limit at 3m (μV/m)	Margin (dBm)
926.75	H	79.8		1.6	26.7	0.0	108.1	253084.4	NA	NA
	V	78.4		1.6	26.7	0.0	106.7	215161.9	NA	NA
1853.50	H	62.8		2.3	31.9	-40.1	56.9	697.2	32824.3	-33.5
	V	64.4		2.3	31.9	-40.1	58.5	838.2	32824.3	-31.9

25. Band-Edge Compliance

EUT Information	
Manufacturer	Chamberlain Group, Inc.
Product	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping

Test Setup Details	
Setup Format	Tabletop
Height of Support	N/A
Measurement Method	Radiated
Type of Test Site	Semi-Anechoic Chamber
Type of Antennas Used	Bilog (or equivalent)
Notes	None

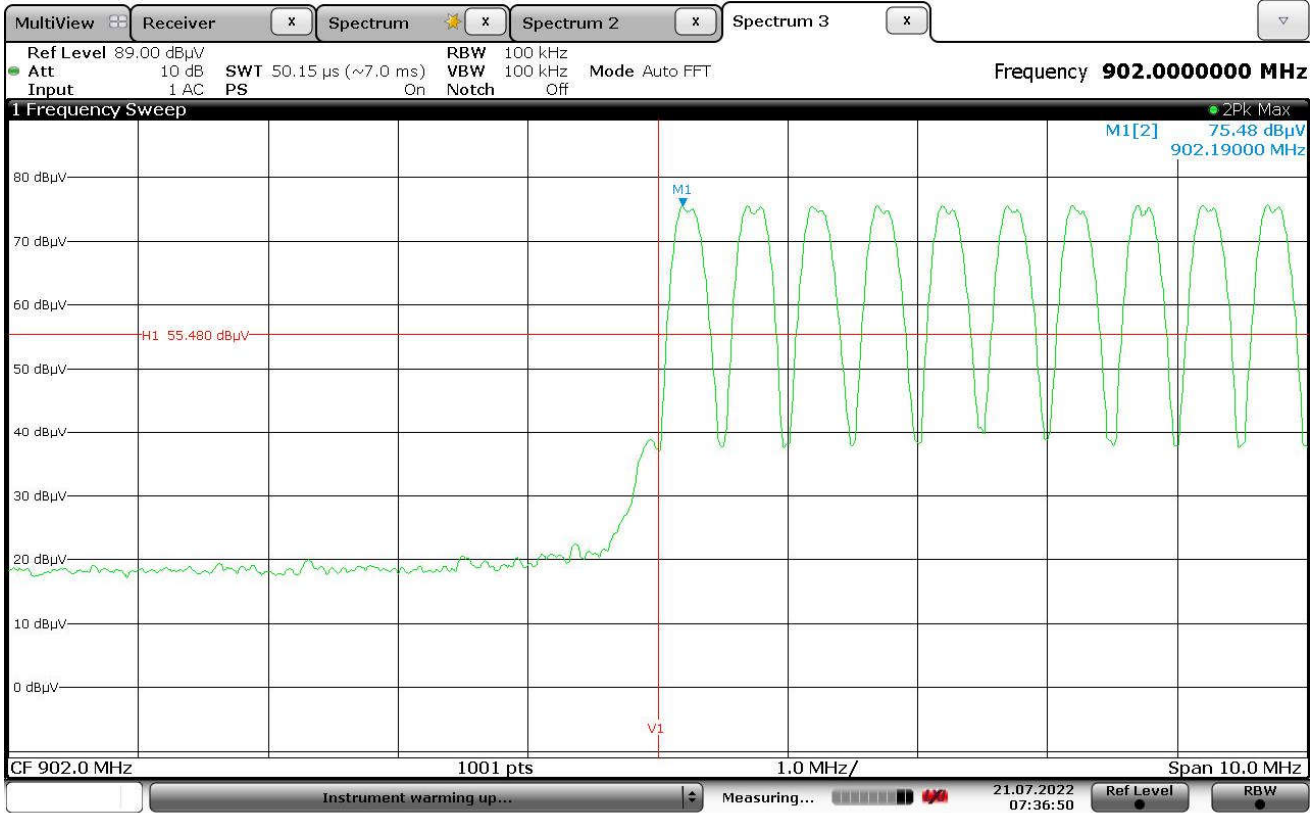
Measurement Uncertainty	
Measurement Type	Expanded Measurement Uncertainty
Radiated disturbance (electric field strength on an open area test site or alternative test site) (30 MHz – 1000 MHz)	4.3
Radiated disturbance (electric field strength on an open area test site or alternative test site) (1 GHz – 6 GHz)	3.1

Procedure
<p>1) Low Band Edge:</p> <ul style="list-style-type: none"> a) The EUT was set up inside the test chamber on a non-conductive stand and a broadband measuring antenna was placed at a test distance of 3 meters from the EUT. b) The EUT was set to transmit with the frequency hopping function enabled. c) The EUT was maximized for worst case emissions at the measuring antenna and the maximum meter reading was recorded. d) To determine the band edge compliance, the following spectrum analyzer settings were used: <ul style="list-style-type: none"> o Center Frequency = 902MHz (low band-edge frequency). o Span = Wide enough to capture the peak level of the emission operating on the channel closest to the band-edge, as well as any modulation products which fall outside of the authorized band of operation. o Resolution Bandwidth (RBW) = $\geq 1\%$ of the span. o 'Max-Hold' function was engaged. e) The analyzer was allowed to scan until the envelope of the transmitter bandwidth was defined. f) The marker was set on the peak of the in-band emissions. A display line was placed 20dB down from the peak of the in-band emissions. All emissions which fall outside of the authorized band of operation must be below the 20dB down display line. (All emissions to the left of the center frequency (band-edge) must be below the display line.) g) The analyzer's display was then screenshot and saved. <p>2) Low Band Edge:</p> <ul style="list-style-type: none"> a) The EUT was set up inside the test chamber on a non-conductive stand and a broadband

measuring antenna was placed at a test distance of 3 meters from the EUT.

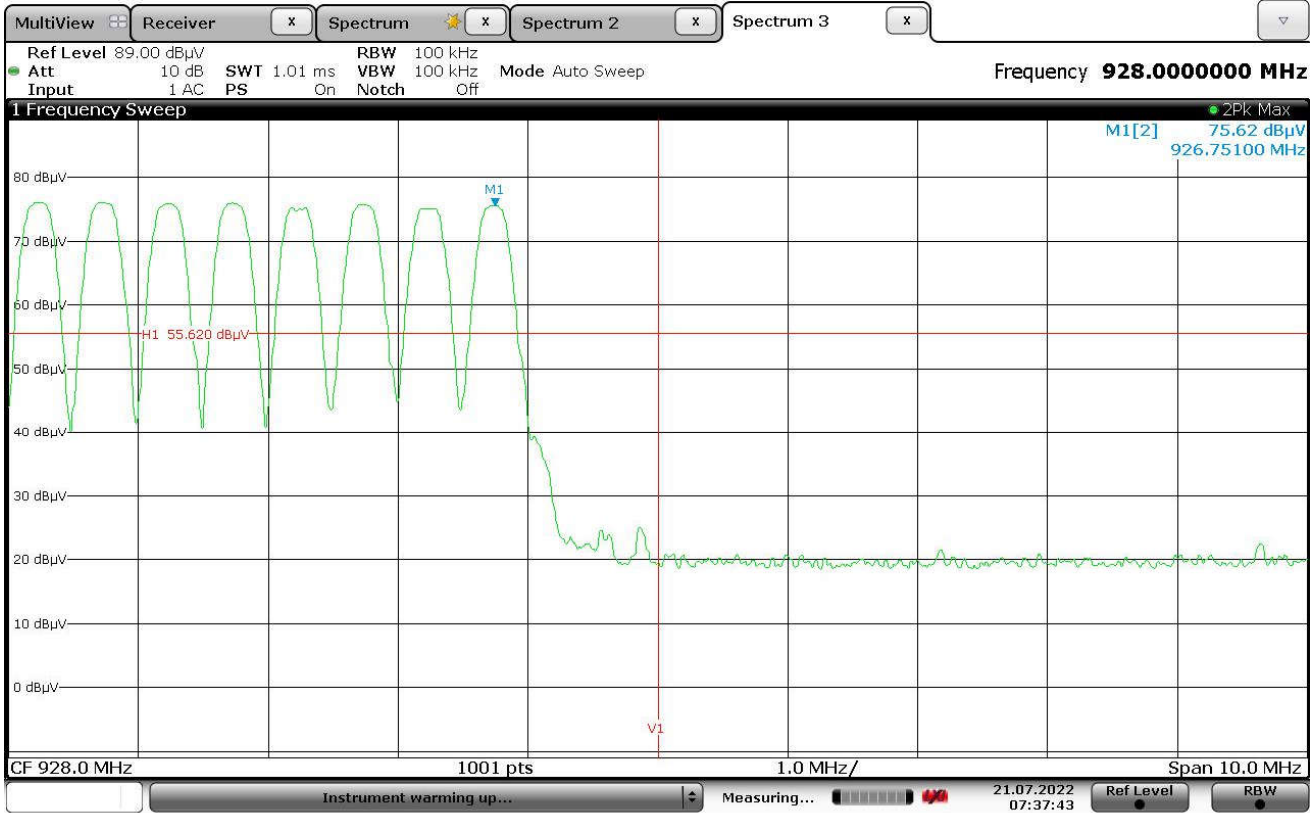
- b) The EUT was set to transmit with the frequency hopping function enabled.
- c) The EUT was maximized for worst case emissions at the measuring antenna and the maximum meter reading was recorded.
- d) To determine the band edge compliance, the following spectrum analyzer settings were used:
 - o Center Frequency = 928MHz (high band-edge frequency).
 - o Span = Wide enough to capture the peak level of the emission operating on the channel closest to the band-edge, as well as any modulation products which fall outside of the authorized band of operation.
 - o Resolution Bandwidth (RBW) = $\geq 1\%$ of the span.
 - o 'Max-Hold' function was engaged.
- e) The analyzer was allowed to scan until the envelope of the transmitter bandwidth was defined.
- f) The marker was set on the peak of the in-band emissions. A display line was placed 20dB down from the peak of the in-band emissions. All emissions which fall outside of the authorized band of operation must be below the 20dB down display line. (All emissions to the left of the center frequency (band-edge) must be below the display line.)
- g) The analyzer's display was then screenshot and saved.

Test Details	
Manufacturer	Chamberlain Group, Inc.
EUT	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping
Frequency Tested	902.75MHz
Notes	Low Band Edge



Date: 21.JUL.2022 07:36:51

Test Details	
Manufacturer	Chamberlain Group, Inc.
EUT	Access Control Unit
Model No.	CAPXLVMC
Serial No.	SMP-90182
Mode	Tx Hopping
Frequency Tested	926.75MHz
Notes	High Band Edge



Date: 21.JUL.2022 07:37:43

26. Scope of Accreditation

SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017

ELITE ELECTRONIC ENGINEERING, INC.
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ELECTRICAL

Valid To: June 30, 2023

Certificate Number: 1786.01

In recognition of the successful completion of the A2LA Accreditation Program evaluation process, accreditation is granted to this laboratory to perform the following automotive electromagnetic compatibility and other electrical tests:

Test Technology:**Test Method(s) 1:*****Transient Immunity***

ISO 7637-2 (including emissions); ISO 7637-3;
ISO 16750-2:2012, Sections 4.6.3 and 4.6.4;
CS-11979, Section 6.4; CS.00054, Section 5.9;
EMC-CS-2009.1 (CI220); FMC1278 (CI220, CI221, CI222);
GMW 3097, Section 3.5; SAE J1113-11; SAE J1113-12;
ECE Regulation 10.06 Annex 10

Electrostatic Discharge (ESD)

ISO 10605 (2001, 2008);
CS-11979 Section 7.0; CS.00054, Section 5.10;
EMC-CS-2009.1 (CI 280); FMC1278 (CI280); SAE J1113-13;
GMW 3097 Section 3.6

Conducted Emissions

CISPR 25 (2002, 2008), Sections 6.2 and 6.3;
CISPR 25 (2016), Sections 6.3 and 6.4;
CS-11979, Section 5.1; CS.00054, Sections 5.6.1 and 5.6.2;
GMW 3097, Section 3.3.2;
EMC-CS-2009.1 (CE 420); FMC1278 (CE420, CE421)

Radiated Emissions Anechoic

CISPR 25 (2002, 2008), Section 6.4;
CISPR 25 (2016), Section 6.5;
CS-11979, Section 5.3; CS.00054, Section 5.6.3;
GMW 3097, Section 3.3.1;
EMC-CS-2009.1 (RE 310); FMC1278 (RE310);
ECE Regulation 10.06 Annex 7 (Broadband)
ECE Regulation 10.06 Annex 8 (Narrowband)

(A2LA Cert. No. 1786.01) Revised 12/17/2021



Page 1 of 8

<u>Test Technology:</u>	<u>Test Method(s) 1:</u>
<i>Vehicle Radiated Emissions</i>	CISPR 12; CISPR 36; ICES-002; ECE Regulation 10.06 Annex 5
<i>Bulk Current Injection (BCI)</i>	ISO 11452-4; CS-11979, Section 6.1; CS.00054, Section 5.8.1; GMW 3097, Section 3.4.1; SAE J1113-4; EMC-CS-2009.1 (RI112); FMCI278 (RI112); ECE Regulation 10.06 Annex 9
<i>Radiated Immunity Anechoic (Including Radar Pulse)</i>	ISO 11452-2; ISO 11452-5; CS-11979, Section 6.2; CS.00054, Section 5.8.2; GMW 3097, Section 3.4.2; EMC-CS-2009.1 (RI114); FMCI278 (RI114); SAE J1113-21; ECE Regulation 10.06 Annex 9
<i>Radiated Immunity Magnetic Field</i>	ISO 11452-8
<i>Radiated Immunity Reverb</i>	ISO/TEC 61000-4-21; GMW 3097, Section 3.4.3; EMC-CS-2009.1 (RI114); FMCI278 (RI114); ISO 11452-11
<i>Radiated Immunity (Portable Transmitters)</i>	ISO 11452-9; EMC-CS-2009.1 (RI115); FMCI278 (RI115)
<i>Vehicle Radiated Immunity (ALSE)</i>	ISO 11451-2; ECE Regulation 10.06 Annex 6
<i>Vehicle Product Specific EMC Standards</i>	EN 14982; EN ISO 13309, ISO 13766; EN 50498; EC Regulation No. 2015/208; EN 55012
<i>Electrical Loads</i>	ISO 16750-2
Emissions Radiated and Conducted (3m Semi-anechoic chamber, up to 40 GHz)	47 CFR, FCC Part 15 B (using ANSI C63.4:2014); 47 CFR, FCC Part 18 (using FCC MP-5:1986); ICES-001; ICES-003; ICES-005; IEC/CISPR 11, Ed. 4.1 (2004-06); AS/NZS CISPR 11 (2004); IEC/CISPR 11 Ed 5 (2009-05) + A1 (2010); KN 11 (2008-5) with RRL Notice No. 2008-3 (May 20, 2008); CISPR 11; EN 55011; KS C 9811; CNS 13803 (1997, 2003); CISPR 14-1; EN 55014-1; AS/NZS CISPR 14.1; KS C 9814-1; KN 14-1; IEC/CISPR 22 (1997); EN 55022 (1998) + A1(2000); EN 55022 (1998) + A1(2000) + A2(2003); EN 55022 (2006); IEC/CISPR 22 (2008-09); AS/NZS CISPR 22 (2004); AS/NZS CISPR 22, 3rd Edition (2006); KN 22 (up to 6 GHz); CNS 13438 (up to 6 GHz); VCCI V-3 (up to 6 GHz); CISPR 32; EN 55032; KS C 9832; KN 32; ECE Regulation 10.06 Annex 14
Cellular Radiated Spurious Emissions	ETSI TS 151 010-1 GSM; 3GPP TS 51.010-1, Sec 12; ETSI TS 134 124 UMTS; 3GPP TS 34.124; ETSI TS 136 124 LTE; E-UTRA; 3GPP TS 36.124

Test Technology:

Test Method(s) 1:

Emissions (cont'd)

Current Harmonics

IEC 61000-3-2; EN 61000-3-2; KN 61000-3-2;
KS C 9610-3-2; ECE Regulation 10.06 Annex 11

Flicker and Fluctuations

IEC 61000-3-3; EN 61000-3-3; KN 61000-3-3;
KS C 9610-3-3; ECE Regulation 10.06 Annex 12

Immunity

Electrostatic Discharge

IEC 61000-4-2, Ed. 1.2 (2001);
IEC 61000-4-2 (1995) + A1(1998) + A2(2000);
EN 61000-4-2 (1995); EN 61000-4-2 (2009-05);
KN 61000-4-2 (2008-5);
RRL Notice No. 2008-4 (May 20, 2008);
IEC 61000-4-2; EN 61000-4-2; KN 61000-4-2;
KS C 9610-4-2; IEEE C37.90.3 2001

Radiated Immunity

IEC 61000-4-3 (1995) + A1(1998) + A2(2000);
IEC 61000-4-3, Ed. 3.0 (2006-02);
IEC 61000-4-3, Ed. 3.2 (2010);
KN 61000-4-3 (2008-5);
RRL Notice No. 2008-4 (May 20, 2008);
IEC 61000-4-3; EN 61000-4-3; KN 61000-4-3;
KS C 9610-4-3; IEEE C37.90.2 2004

Electrical Fast Transient/Burst

IEC 61000-4-4, Ed. 2.0 (2004-07);
IEC 61000-4-4, Ed. 2.1 (2011);
IEC 61000-4-4 (1995) + A1(2000) + A2(2001);
KN 61000-4-4 (2008-5);
RRL Notice No. 2008-5 (May 20, 2008);
IEC 61000-4-4; EN 61000-4-4; KN 61000-4-4;
KS C 9610-4-4; ECE Regulation 10.06 Annex 15

Surge

IEC 61000-4-5 (1995) + A1(2000);
IEC 61000-4-5, Ed 1.1 (2005-11);
EN 61000-4-5 (1995) + A1(2001);
KN 61000-4-5 (2008-5);
RRL Notice No. 2008-4 (May 20, 2008);
IEC 61000-4-5; EN 61000-4-5; KN 61000-4-5;
KS C 9610-4-5;
IEEE C37.90.1 2012; IEEE STD C62.41.2 2002;
ECE Regulation 10.06 Annex 16

Conducted Immunity

IEC 61000-4-6 (1996) + A1(2000);
IEC 61000-4-6, Ed 2.0 (2006-05);
IEC 61000-4-6 Ed. 3.0 (2008);
KN 61000-4-6 (2008-5);
RRL Notice No. 2008-4 (May 20, 2008);
EN 61000-4-6 (1996) + A1(2001); IEC 61000-4-6;
EN 61000-4-6; KN 61000-4-6; KS C 9610-4-6

Test Technology:

Test Method(s) 1:

Immunity (cont'd)

Power Frequency Magnetic Field
Immunity (*Down to 3 A/m*)

IEC 61000-4-8 (1993) + A1(2000); IEC 61000-4-8 (2009);
EN 61000-4-8 (1994) + A1(2000);
KN 61000-4-8 (2008-5);
RRL Notice No. 2008-4 (May 20, 2008);
IEC 61000-4-8; EN 61000-4-8; KN 61000-4-8; KS C 9610-4-8

Voltage Dips, Short Interrupts, and Line
Voltage Variations

IEC 61000-4-11, Ed. 2 (2004-03);
KN 61000-4-11 (2008-5);
RRL Notice No. 2008-4 (May 20, 2008);
IEC 61000-4-11; EN 61000-4-11; KN 61000-4-11;
KS C 9610-4-11

Ring Wave

IEC 61000-4-12, Ed. 2 (2006-09);
EN 61000-4-12:2006;
IEC 61000-4-12; EN 61000-4-12; KN 61000-4-12;
IEEE STD C62.41.2 2002

Generic and Product Specific EMC
Standards

IEC/EN 61000-6-1; AS/NZS 61000-6-1; KN 61000-6-1;
KS C 9610-6-1; IEC/EN 61000-6-2; AS/NZS 61000-6-2;
KN 61000-6-2; KS C 9610-6-2; IEC/EN 61000-6-3;
AS/NZS 61000-6-3; KN 61000-6-3; KS C 9610-6-3;
IEC/EN 61000-6-4; AS/NZS 61000-6-4; KN 61000-6-4;
KS C 9610-6-4; EN 50130-4; EN 61326-1; EN 50121-3-2;
EN 12895; EN 50270; EN 50491-1; EN 50491-2; EN 50491-3;
EN 55015; EN 60730-1; EN 60945; IEC 60533;
EN 61326-2-6; EN 61800-3; IEC/CISPR 14-2; EN 55014-2;
AS/NZS CISPR 14.2; KN 14-2; KS C 9814-2;
IEC/CISPR 24; AS/NZS CISPR 24; EN 55024; KN 24;
IEC/CISPR 35; AS/NZS CISPR 35; EN 55035; KN 35;
KS C 9835; IEC 60601-1-2; JIS T0601-1-2

TxRx EMC Requirements

EN 301 489-1; EN 301 489-3; EN 301 489-9; EN 301 489-17;
EN 301 489-19; EN 301 489-20

European Radio Test Standards

ETSI EN 300 086-1; ETSI EN 300 086-2;
ETSI EN 300 113-1; ETSI EN 300 113-2;
ETSI EN 300 220-1; ETSI EN 300 220-2;
ETSI EN 300 220-3-1; ETSI EN 300 220-3-2;
ETSI EN 300 330-1; ETSI EN 300 330-2;
ETSI EN 300 440-1; ETSI EN 300 440-2;
ETSI EN 300 422-1; ETSI EN 300 422-2;
ETSI EN 300 328; ETSI EN 301 893;
ETSI EN 301 511; ETSI EN 301 908-1;
ETSI EN 908-2; ETSI EN 908-13;
ETSI EN 303 413; ETSI EN 302 502;
EN 303 340; EN 303 345-2; EN 303 345-3; EN 303 345-4

Test Technology:

Test Method(s) 1:

Canadian Radio Tests

RSS-102 (RF Exposure Evaluation only); RSS-111; RSS-112; RSS-117; RSS-119; RSS-123; RSS-125; RSS-127; RSS-130; RSS-131; RSS-132; RSS-133; RSS-134; RSS-135; RSS-137; RSS-139; RSS-140; RSS-141; RSS-142; RSS-170; RSS-181; RSS-182; RSS-191; RSS-192; RSS-194; RSS-195; RSS-196; RSS-197; RSS-199; RSS-210; RSS-211; RSS-213; RSS-215; RSS-216; RSS-220; RSS-222; RSS-236; RSS-238; RSS-243; RSS-244; RSS-247; RSS-248; RSS-251; RSS-252; RSS-287; RSS-288; RSS-310; RSS-GEN

Mexico Radio Tests

IFT-008-2015; NOM-208-SCFT-2016

Japan Radio Tests

Radio Law No. 131, Ordinance of MPT No. 37, 1981, MIC Notification No. 88:2004, Table No. 22-11; ARIB STD-T66, Regulation 18

Taiwan Radio Tests

LP-0002 (July 15, 2020)

Australia/New Zealand Radio Tests

AS/NZS 4268; Radiocommunications (Short Range Devices) Standard (2014)

Hong Kong Radio Tests

HKCA 1039 Issue 6; HKCA 1042; HKCA 1033 Issue 7; HKCA 1061; HKCA 1008; HKCA 1043; HKCA 1057; HKCA 1073

Korean Radio Test Standards

KN 301 489-1; KN 301 489-3; KN 301 489-9; KN 301 489-17; KN 301 489-52; KS X 3124; KS X 3125; KS X 3130; KS X 3126; KS X 3129

Vietnam Radio Test Standards

QCVN 47:2015/BTTTT; QCVN 54:2020/BTTTT; QCVN 55:2011/BTTTT; QCVN 65:2013/BTTTT; QCVN 73:2013/BTTTT; QCVN 74:2020/BTTTT; QCVN 112:2017/BTTTT; QCVN 117:2020/BTTTT

Vietnam EMC Test Standards

QCVN 18:2014/BTTTT; QCVN 86:2019/BTTTT; QCVN 96:2015/BTTTT; QCVN 118:2018/BTTTT

*Unlicensed Radio Frequency Devices
(3 Meter Semi-Anechoic Room.)*

47 CFR FCC Part 15C, 15D, 15E, 15F, 15G, 15H (using ANSI C63.10:2013, ANSI C63.17:2013 and FCC KDB 905462 D02 (v02))

Licensed Radio Service Equipment

47 CFR FCC Parts 20, 22, 24, 25, 27, 30, 73, 74, 80, 87, 90, 95, 96, 97, 101 (using ANSI/TIA-603-E, TIA-102.CAAA-E, ANSI C63.26:2015)

Test Technology:

OTA (Over the Air) Performance
 GSM, GPRS, EGPRS
 UMTS (W-CDMA)
 LTE including CAT M1
 A-GPS for UMTS/GSM
 LRS A-GPS, A-GLONASS,
 STB8/STB16
 Large Device/Laptop/Tablet Testing
 Integrated Device Testing
 WiFi 802.11 a/b/g/n/a

Test Method(s) ¹:

CTIA Test Plan for Wireless Device Over-the-Air Performance (Method for Measurement for Radiated Power and Receiver Performance) V3.8.2;
 CTIA Test Plan for RF Performance Evaluation of WiFi Mobile Converged Devices V2.1.0

Electrical Measurements and Simulation

AC Voltage / Current

(1mV to 5kV) 60 Hz
 (0.1V to 250V) up to 500 MHz
 (1µA to 150A) 60 Hz

FAA AC 150/5345-10H
 FAA AC 150/5345-43J
 FAA AC 150/5345-44K

DC Voltage / Current

(1mV to 15-kV) / (1µA to 10A)

FAA AC 150/5345-46E

Power Factor / Efficiency / Crest Factor

(Power to 30kW)

FAA AC 150/5345-47C
 FAA EB 67D

Resistance

(1mΩ to 4000MΩ)

Surge

(Up to 10 kV / 5 kA) (Combination Wave and Ring Wave)

On the following products and materials:

Telecommunications Terminal Equipment (TTE), Radio Equipment, Network Equipment, Information Technology Equipment (ITE), Automotive Electronic Equipment, Automotive Hybrid Electronic Devices, Maritime Navigation and Radio Communication Equipment and Systems, Vehicles, Boats and Internal Combustion Engine Driven Devices, Automotive, Aviation, and General Lighting Products, Medical Electrical Equipment, Motors, Industrial, Scientific and Medical (ISM) Radio-Frequency Equipment, Household Appliances, Electric Tools, Low-voltage Switchgear and Control gear, Programmable Controllers, Electrical Equipment for Measurement, Control and Laboratory Use, Base Materials, Power and Data Transmission Cables and Connectors

¹ When the date, edition, version, etc. is not identified in the scope of accreditation, laboratories may use the version that immediately precedes the current version for a period of one year from the date of publication of the standard measurement method, per part C., Section 1 of A2LA R101 - *General Requirements - Accreditation of ISO-IEC 17025 Laboratories*.

Testing Activities Performed in Support of FCC Certification in Accordance with 47 Code of Federal Regulations and FCC KDB 974614, Appendix A, Table A.1²

Rule Subpart/Technology	Test Method	Maximum Frequency (MHz)
<u>Unintentional Radiators</u> Part 15B	ANSI C63.4:2014	40000

Testing Activities Performed in Support of FCC Certification in Accordance with 47 Code of Federal Regulations and FCC KDB 974614, Appendix A, Table A.1²

Rule Subpart/Technology	Test Method	Maximum Frequency (MHz)
<u>Industrial, Scientific, and Medical Equipment</u> Part 18	FCC MP-5 (February 1986)	40000
<u>Intentional Radiators</u> Part 15C	ANSI C63.10:2013	40000
<u>Unlicensed Personal Communication Systems Devices</u> Part 15D	ANSI C63.17:2013	40000
<u>U-NII without DFS Intentional Radiators</u> Part 15E	ANSI C63.10:2013	40000
<u>U-NII with DFS Intentional Radiators</u> Part 15E	FCC KDB 905462 D02 (v02)	40000
<u>UWB Intentional Radiators</u> Part 15F	ANSI C63.10:2013	40000
<u>BPL Intentional Radiators</u> Part 15G	ANSI C63.10:2013	40000
<u>White Space Device Intentional Radiators</u> Part 15H	ANSI C63.10:2013	40000
<u>Commercial Mobile Services (FCC Licensed Radio Service Equipment)</u> Parts 22 (cellular), 24, 25 (below 3 GHz), and 27	ANSI/TIA-603-E; TIA-102.CAAA-E; ANSI C63.26:2015	40000
<u>General Mobile Radio Services (FCC Licensed Radio Service Equipment)</u> Parts 22 (non-cellular), 90 (below 3 GHz), 95, 97, and 101 (below 3 GHz)	ANSI/TIA-603-E; TIA-102.CAAA-E; ANSI C63.26:2015	40000
<u>Citizens Broadband Radio Services (FCC Licensed Radio Service Equipment)</u> Part 96	ANSI/TIA-603-E; TIA-102.CAAA-E; ANSI C63.26:2015	40000

Testing Activities Performed in Support of FCC Certification in Accordance with 47 Code of Federal Regulations and FCC KDB 974614, Appendix A, Table A.1²

Rule Subpart/Technology	Test Method	Maximum Frequency (MHz)
<u>Maritime and Aviation Radio Services</u> Parts 80 and 87	ANSI/TIA-603-E; ANSI C63.26:2015	40000
<u>Microwave and Millimeter Bands Radio Services</u> Parts 25, 30, 74, 90 (above 3 GHz), 97 (above 3 GHz), and 101	ANSI/TIA-603-E; TIA-102.CAAA-E; ANSI C63.26:2015	40000
<u>Broadcast Radio Services</u> Parts 73 and 74 (below 3 GHz)	ANSI/TIA-603-E; TIA-102.CAAA-E; ANSI C63.26:2015	40000
<u>Signal Boosters</u> Part 20 (Wideband Consumer Signal Boosters, Provider-specific signal boosters, and Industrial Signal Boosters) Section 90.219	ANSI C63.26:2015	40000

² Accreditation does not imply acceptance to the FCC equipment authorization program. Please see the FCC website (<https://apps.fcc.gov/oetcf/eas/>) for a listing of FCC approved laboratories.



Accredited Laboratory

A2LA has accredited

ELITE ELECTRONIC ENGINEERING INC.

Downers Grove, IL

for technical competence in the field of

Electrical Testing

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017 *General requirements for the competence of testing and calibration laboratories*. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).



Presented this 19th day of May 2021.



Vice President, Accreditation Services
For the Accreditation Council
Certificate Number 1786.01
Valid to June 30, 2023

For the tests to which this accreditation applies, please refer to the laboratory's Electrical Scope of Accreditation.